

Search Notes

Application/Control No.

10/511,607

Examiner

B. Chen

Applicant(s)/Patent under
Reexamination

HAMA ET AL.

Art Unit

1762

SEARCHED

Class	Subclass	Date	Examiner
134	21 22.12 22.18	3/15/2006	BC
	34 37 198		
118	723R 723E		
	733		
427	569 577		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	3/15/2006	BC
discussed FOS with SPE Barr discussed FOS with Examiner Zervigon		
discussed rejection w/ Examiner Talbot		